

Notice of References Cited

Application/Control No.

10/522,434

Applicant(s)/Patent Under
Reexamination
RICHTER ET AL.

Examiner

MICHAEL SHANNON

Art Unit

2612

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,861,944	03-2005	Hoepelman, Jakob	340/5.1
*	B	US-5,960,085	09-1999	de la Hueriga, Carlos	340/5.61
*	C	US-6,580,356	06-2003	Alt et al.	340/5.8
*	D	US-5,914,701	06-1999	Gershenfeld et al.	345/156
*	E	US-6,563,940	05-2003	Recce, Michael	382/120
*	F	US-3,897,058	07-1975	Koch, Alvin F.	473/206
*	G	US-5,583,386	12-1996	Meixner et al.	307/326
*	H	US-4,643,263	02-1987	Karden, Karl G.	173/168
*	I	US-2003/0184430	10-2003	Kumar, Alok	340/5.2
*	J	US-5,554,979	09-1996	Kohar et al.	340/825.72
*	K	US-2002/0196123	12-2002	Diehl et al.	340/5.64
*	L	US-6,414,587	07-2002	Fitzgibbon, James J.	340/5.22
*	M	US-6,832,987	12-2004	David et al.	600/300

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.